



Date: November 6, 2020

Federal Communications Commission
Office of Engineering and Technology Laboratory Division
7435 Oakland Mills Rd.
Columbia MD 21046

Attn: Office of Engineering and Technology

HAC Attestation - FCC ID: A3LSMG996B

To whom it may concern:

Samsung Electronics Co., Ltd. hereby declares that the MIF values detailed below are based on worst case operating modes for all air interfaces for which the HAC rating is provided based on the current methodology for determining MIF values.

Reference Test report Number(s): UL Korea Test Report 4789633488.

SPEAG test files

UID	Communication System Name	MIF (dB)
10021-DAC	GSM-FDD (TDMA, GMSK)	3.63
10011-CAB	UMTS-FDD (WCDMA)	-27.23
10170-CAE	LTE-FDD (SC-FDMA, 1 RB, 20 MHz, 16QAM)	-9.76
10182-CAE	LTE-FDD (SC-FDMA, 1 RB, 15 MHz, 16QAM)	-9.76
10176-CAF	LTE-FDD (SC-FDMA, 1 RB, 10 MHz, 16QAM)	-9.76
10173-CAG	LTE-TDD (SC-FDMA, 1 RB, 20 MHz, 16QAM)	-1.44
10931-AAA	5G NR (DFT-s-OFDM, 1 RB, 20 MHz, QPSK)	-15.06
10061-CAB	IEEE 802.11b WiFi 2.4 GHz (DSSS, 11 Mbps)	-2.02
10077-CAB	IEEE 802.11g WiFi 2.4 GHz (DSSS/OFDM, 54 Mbps)	0.12
10069-CAC	IEEE 802.11a/h WiFi 5 GHz (OFDM, 54 Mbps)	-3.15
10671-AAC	IEEE 802.11ax (20MHz, MCS0, 90pc duty cycle)	-5.58

Sincerely,

Name Sanghoon Kim
Title CL3
On behalf of Samsung Electronics Co., Ltd..